

74LVT573

3.3 V octal D-type transparent latch; 3-state

Rev. 8 — 22 November 2011

Product data sheet

1. General description

The 74LVT573 is a high-performance BiCMOS product designed for V_{CC} operation at 3.3 V. This device is an octal transparent latch coupled to eight 3-state output buffers. The two sections of the device are controlled independently by Latch Enable (LE) and Output Enable (\overline{OE}) control gates. The 74LVT573 has a broadside pinout configuration to facilitate PC board layout and allow easy interface with microprocessors.

The data on the Dn inputs are transferred to the latch outputs when the Latch Enable (LE) input is High. The latch remains transparent to the data inputs while LE is High, and stores the data that is present one setup time before the High-to-Low enable transition.

The 3-state output buffers are designed to drive heavily loaded 3-state buses, MOS memories, or MOS microprocessors. The active-Low Output Enable (\overline{OE}) controls all eight 3-state buffers independent of the latch operation.

When \overline{OE} is Low, the latched or transparent data appears at the outputs. When \overline{OE} is High, the outputs are in the High-impedance "OFF" state, which means they will neither drive nor load the bus.

2. Features and benefits

- Inputs and outputs arranged for easy interfacing to microprocessors
- 3-state outputs for bus interfacing
- Common output enable control
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus hold data inputs eliminate need for external pull-up resistors to hold unused inputs
- Live insertion and extraction permitted
- No bus current loading when output is tied to 5 V bus
- Power-up reset
- Power-up 3-state
- Latch-up protection
 - ◆ JESD78 class II exceeds 500 mA
- ESD protection:
 - ◆ HBM JESD22-A114E exceeds 2000 V
 - ◆ MM JESD22-A115-A exceeds 200 V
- Specified from $-40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$



3. Ordering information

Table 1. Ordering information

Type number	Package			Version
	Temperature range	Name	Description	
74LVT573D	-40 °C to +85 °C	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1
74LVT573DB	-40 °C to +85 °C	SSOP20	plastic shrink small outline package; 20 leads; body width 5.3 mm	SOT339-1
74LVT573PW	-40 °C to +85 °C	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1
74LVT573BQ	-40 °C to +85 °C	DHVQFN20	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body 2.5 × 4.5 × 0.85 mm	SOT764-1

4. Functional diagram

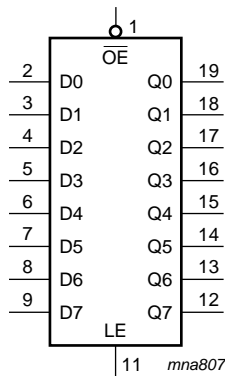


Fig 1. Logic symbol

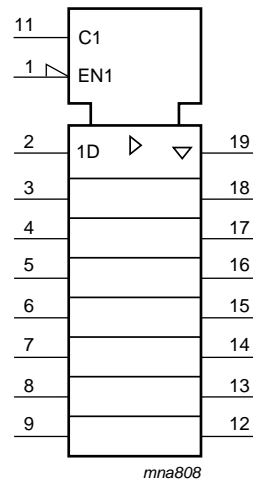


Fig 2. IEC logic symbol

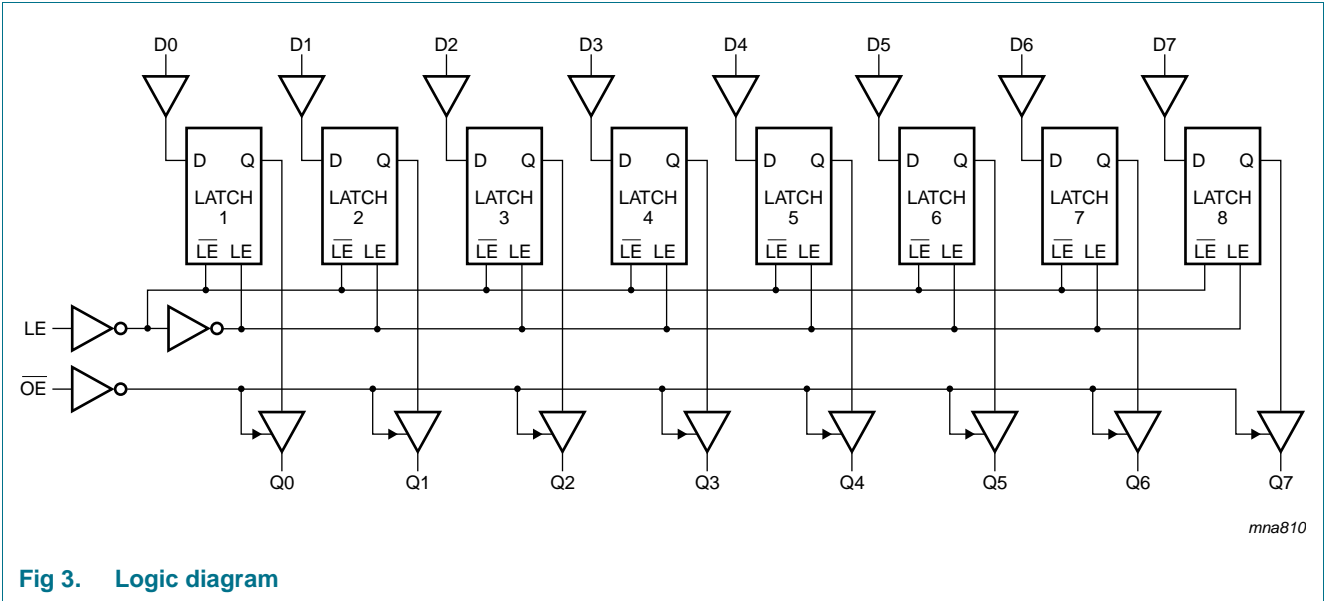


Fig 3. Logic diagram

5. Pinning information

5.1 Pinning

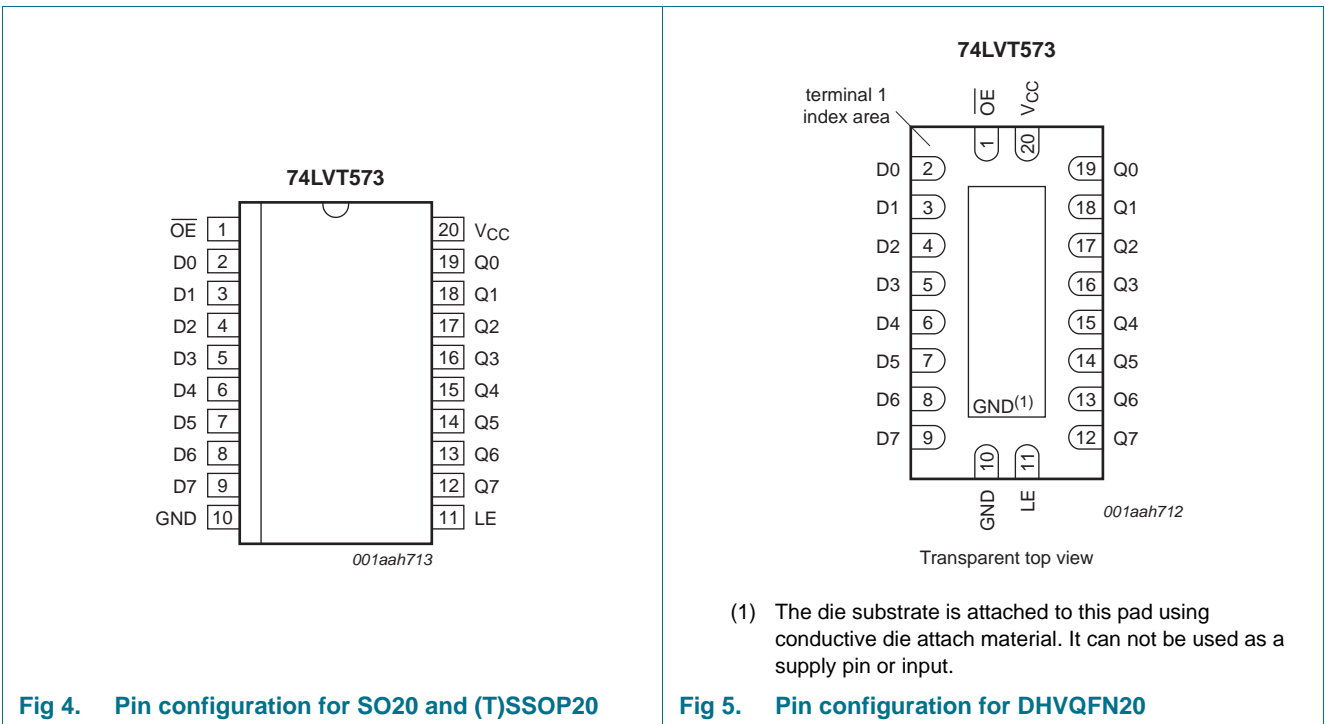


Fig 4. Pin configuration for SO20 and (T)SSOP20

Fig 5. Pin configuration for DHVQFN20

5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
\overline{OE}	1	output enable input (active LOW)
D0 to D7	2, 3, 4, 5, 6, 7, 8, 9	data input
GND	10	ground (0 V)
LE	11	latch enable (active HIGH)
Q0 to Q7	19, 18, 17, 16, 15, 14, 13, 12	data output
V_{CC}	20	supply voltage

6. Functional description

6.1 Function table

Table 3. Function table [\[1\]](#)

Operating mode	Control \overline{OE}	Control LE	Input Dn	Internal register	Output Qn
Load and read register enable	L	H	L	L	L
			H	H	H
Latch and read register	L	↓	l	L	L
			h	H	H
Hold	L	L	X	NC	NC
Disable outputs	H	L	X	NC	Z
		H	Dn	Dn	Z

- [1] H = HIGH voltage level;
 L = LOW voltage level;
 ↓ = HIGH-to-LOW latch enable transition;
 h = HIGH voltage level one setup time prior to the LOW-to-HIGH clock transition;
 l = LOW voltage level one setup time prior to the LOW-to-HIGH clock transition;
 Z = high-impedance OFF-state;
 NC = no change;
 X = don't care.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+4.6	V
V_I	input voltage		[1] -0.5	+7.0	V
V_O	output voltage	output in OFF-state or HIGH-state	[1] -0.5	+7.0	V
I_{IK}	input clamping current	$V_I < 0$ V	-	-50	mA
I_{OK}	output clamping current	$V_O < 0$ V	-	-50	mA
I_O	output current	output in LOW-state	-	128	mA
		output in HIGH-state	-	-64	mA

Table 4. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		[2] -	150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +85 °C	[3] -	500	mW

- [1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- [2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.
- [3] For SO20 packages: above 70 °C derate linearly with 8 mW/K.
For SSOP20 and TSSOP20 packages: above 60 °C derate linearly with 5.5 mW/K.
For DHVQFN20 packages: above 60 °C derate linearly with 4.5 mW/K.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V _{CC}	supply voltage		2.7	-	3.6	V
V _i	input voltage		0	-	5.5	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-	-	-32	mA
I _{OL}	LOW-level output current		-	-	32	mA
		current duty cycle ≤ 50 %; f _i ≥ 1 kHz	-	-	64	mA
T _{amb}	ambient temperature	in free air	-40	-	+85	°C
Δt/ΔV	input transition rise and fall rate	outputs enabled	-	-	10	ns/V

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T _{amb} = -40 °C to +85 °C			Unit
			Min	Typ ^[1]	Max	
V _{IK}	input clamping voltage	V _{CC} = 2.7 V; I _{IK} = -18 mA	-1.2	-0.9	-	V
V _{OH}	HIGH-level output voltage	V _{CC} = 2.7 V to 3.6 V; I _{OH} = -100 μA	V _{CC} - 0.2	V _{CC} - 0.1	-	V
		V _{CC} = 2.7 V; I _{OH} = -8 mA	2.4	2.5	-	V
		V _{CC} = 3.0 V; I _{OH} = -32 mA	2.0	2.2	-	V
V _{OL}	LOW-level output voltage	V _{CC} = 2.7 V; I _{OL} = 100 μA	-	0.1	0.2	V
		V _{CC} = 2.7 V; I _{OL} = 24 mA	-	0.3	0.5	V
		V _{CC} = 3.0 V I _{OL} = 16 mA	-	0.25	0.4	V
		V _{CC} = 3.0 V I _{OL} = 32 mA	-	0.3	0.5	V
		V _{CC} = 3.0 V I _{OL} = 64 mA	-	0.4	0.55	V
V _{OL(pu)}	power-up LOW-level output voltage	V _{CC} = 3.6 V; I _O = 1 mA; V _i = GND or V _{CC}	[2] -	0.13	0.55	V

Table 6. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T _{amb} = -40 °C to +85 °C			Unit
			Min	Typ ^[1]	Max	
I _I	input leakage current	all input pins;				
		V _{CC} = 0 V or 3.6 V; V _I = 5.5 V	-	1	10	μA
		control pins;				
		V _{CC} = 3.6 V; V _{CC} or GND	-	±0.1	±1	μA
I _{OFF}	power-off leakage current	data pins				
		V _{CC} = 3.6 V; V _I = V _{CC} ^[3]	-	0.1	1	μA
		V _{CC} = 3.6 V; V _I = 0 V	-5	-1	-	μA
I _{BHL}	bus hold LOW current	V _{CC} = 0 V; V _I or V _O = 0 V to 4.5 V	-	1	±100	μA
I _{BHL}	bus hold LOW current	Dn input; V _{CC} = 3 V; V _I = 0.8 V ^[4]	75	150	-	μA
I _{BHH}	bus hold HIGH current	Dn input; V _{CC} = 3 V; V _I = 2.0 V	-	-150	-75	μA
I _{BHHO}	bus hold HIGH overdrive current	Dn input; V _{CC} = 3.6; V _I = 0 V to 3.6 V ^[4]	-	-	500	μA
I _{BHLO}	bus hold LOW overdrive current	Dn input; V _{CC} = 3.6; V _I = 0 V to 3.6 V	-500	-	-	μA
I _{LO}	output leakage current	Qn output HIGH when V _O = 5.5 V and V _{CC} = 3.0 V	-	60	125	μA
I _{O(pu/pd)}	power-up/power-down output current	V _{CC} ≤ 1.2 V; V _O = 0.5 V to V _{CC} ; V _I = GND or V _{CC} ; \overline{OE} = don't care ^[5]	-	1	±100	μA
I _{OZ}	OFF-state output current	V _{CC} = 3.6 V; V _I = V _{IH} or V _{IL}				
		output HIGH: V _O = 3.0 V	-	1	5	μA
		output LOW: V _O = 0.5 V	-5	-1	-	μA
I _{CC}	supply current	V _{CC} = 3.6 V; V _I = GND or V _{CC} ; I _O = 0 A				
		outputs HIGH	-	0.13	0.19	mA
		outputs LOW	-	3	12	mA
		outputs disabled ^[6]	-	0.13	0.19	mA
ΔI _{CC}	additional supply current	per input pin; V _{CC} = 3 V to 3.6 V; one input at V _{CC} - 0.6 V and other inputs at V _{CC} or GND ^[7]	-	0.1	0.2	mA
C _I	input capacitance	V _I = 0 V or 3.0 V	-	4	-	pF
C _O	output capacitance	outputs disabled; V _O = 0 V or 3.0 V	-	8	-	pF

- [1] Typical values are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.
- [2] For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.
- [3] Unused pins at V_{CC} or GND.
- [4] This is the bus hold overdrive current required to force the input to the opposite logic state.
- [5] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms. From V_{CC} = 1.2 V to V_{CC} = 3.3 V ± 0.3 V a transition time of 100 μs is permitted. This parameter is valid for T_{amb} = 25 °C only.
- [6] I_{CC} is measured with outputs pulled to V_{CC} or GND.
- [7] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.

10. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to ground ($GND = 0\text{ V}$); for test circuit see [Figure 11](#).

Symbol	Parameter	Conditions	$T_{amb} = -40\text{ °C to }+85\text{ °C}$			Unit
			Min	Typ ^[1]	Max	
t_{PLH}	LOW to HIGH propagation delay	LE to Qn; see Figure 6				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.6	3.5	5.6	ns
		$V_{CC} = 2.7\text{ V}$	-	-	6.3	ns
		Dn to Qn; see Figure 7				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.0	2.5	4.2	ns
		$V_{CC} = 2.7\text{ V}$	-	-	4.7	ns
t_{PHL}	HIGH to LOW propagation delay	LE to Qn; see Figure 6				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	2.5	4.3	6.5	ns
		$V_{CC} = 2.7\text{ V}$	-	-	7.2	ns
		Dn to Qn; see Figure 7				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.0	2.7	4.3	ns
		$V_{CC} = 2.7\text{ V}$	-	-	5.2	ns
t_{PZH}	OFF-state to HIGH propagation delay	\overline{OE} to Qn; see Figure 8				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.0	2.8	5.1	ns
		$V_{CC} = 2.7\text{ V}$	-	-	6.2	ns
t_{PZL}	OFF-state to LOW propagation delay	\overline{OE} to Qn; see Figure 9				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.3	3.3	5.5	ns
		$V_{CC} = 2.7\text{ V}$	-	-	6.6	ns
t_{PHZ}	HIGH to OFF-state propagation delay	\overline{OE} to Qn; see Figure 8				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	2.0	3.7	5.7	ns
		$V_{CC} = 2.7\text{ V}$	-	-	6.7	ns
t_{PLZ}	LOW to OFF-state propagation delay	\overline{OE} to Qn; see Figure 9				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.5	3.0	4.6	ns
		$V_{CC} = 2.7\text{ V}$	-	-	5.1	ns
t_{su}	set-up time	Dn to LE; see Figure 10 ^[2]				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	0.7	-	-	ns
		$V_{CC} = 2.7\text{ V}$	0.6	-	-	ns
t_h	hold time	Dn to LE; see Figure 10 ^[3]				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	1.6	-	-	ns
		$V_{CC} = 2.7\text{ V}$	1.8	-	-	ns
t_w	pulse width	LE input HIGH; see Figure 6 ^[4]				
		$V_{CC} = 3.0\text{ V to }3.6\text{ V}$	3.3	-	-	ns
		$V_{CC} = 2.7\text{ V}$	3.3	-	-	ns

[1] Typical values are at $V_{CC} = 3.3\text{ V}$ and $T_{amb} = 25\text{ °C}$.

[2] t_{su} is the same as $t_{su(L)}$ and $t_{su(H)}$.

[3] t_h is the same as $t_{h(L)}$ and $t_{h(H)}$.

[4] t_w is the same as t_{wL} and t_{wH} .

11. Waveforms

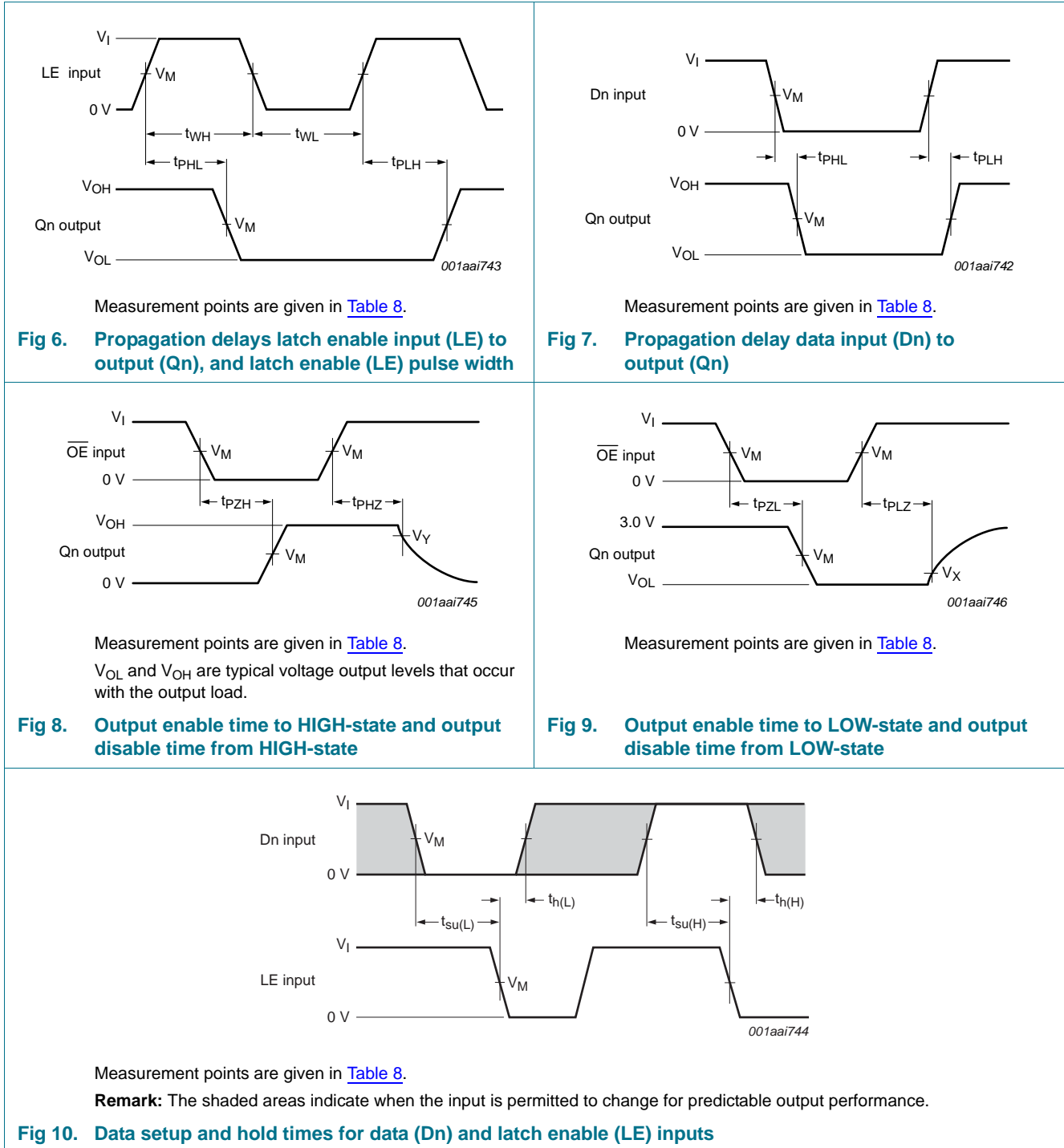
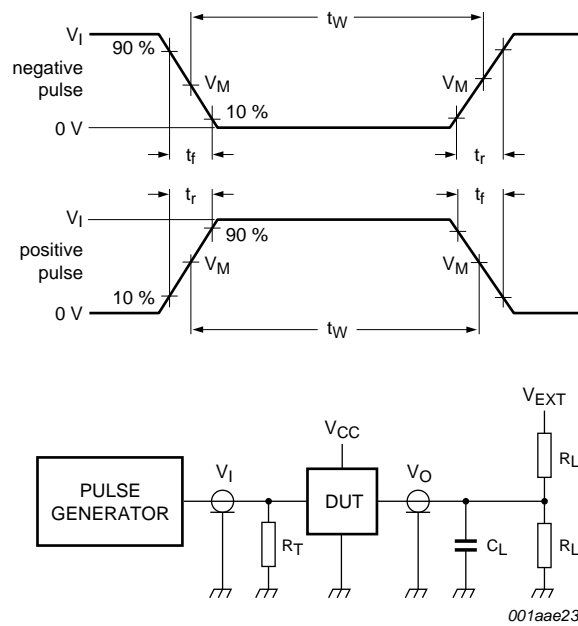


Table 8. Measurement points

Input	Output		
V_M	V_M	V_X	V_Y
1.5 V	1.5 V	$V_{OL} + 0.3 V$	$V_{OH} - 0.3 V$



Test data is given in [Table 9](#).

Definitions test circuit:

R_L = Load resistance.

C_L = Load capacitance including jig and probe capacitance.

R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

V_{EXT} = Test voltage for switching times.

Fig 11. Test circuitry for switching times

Table 9. Test data

Input				Load		V_{EXT}		
V_I	f_i	t_W	t_r, t_f	C_L	R_L	t_{PHZ}, t_{PZH}	t_{PLZ}, t_{PZL}	t_{PLH}, t_{PHL}
2.7 V	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V	open

12. Package outline

SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1

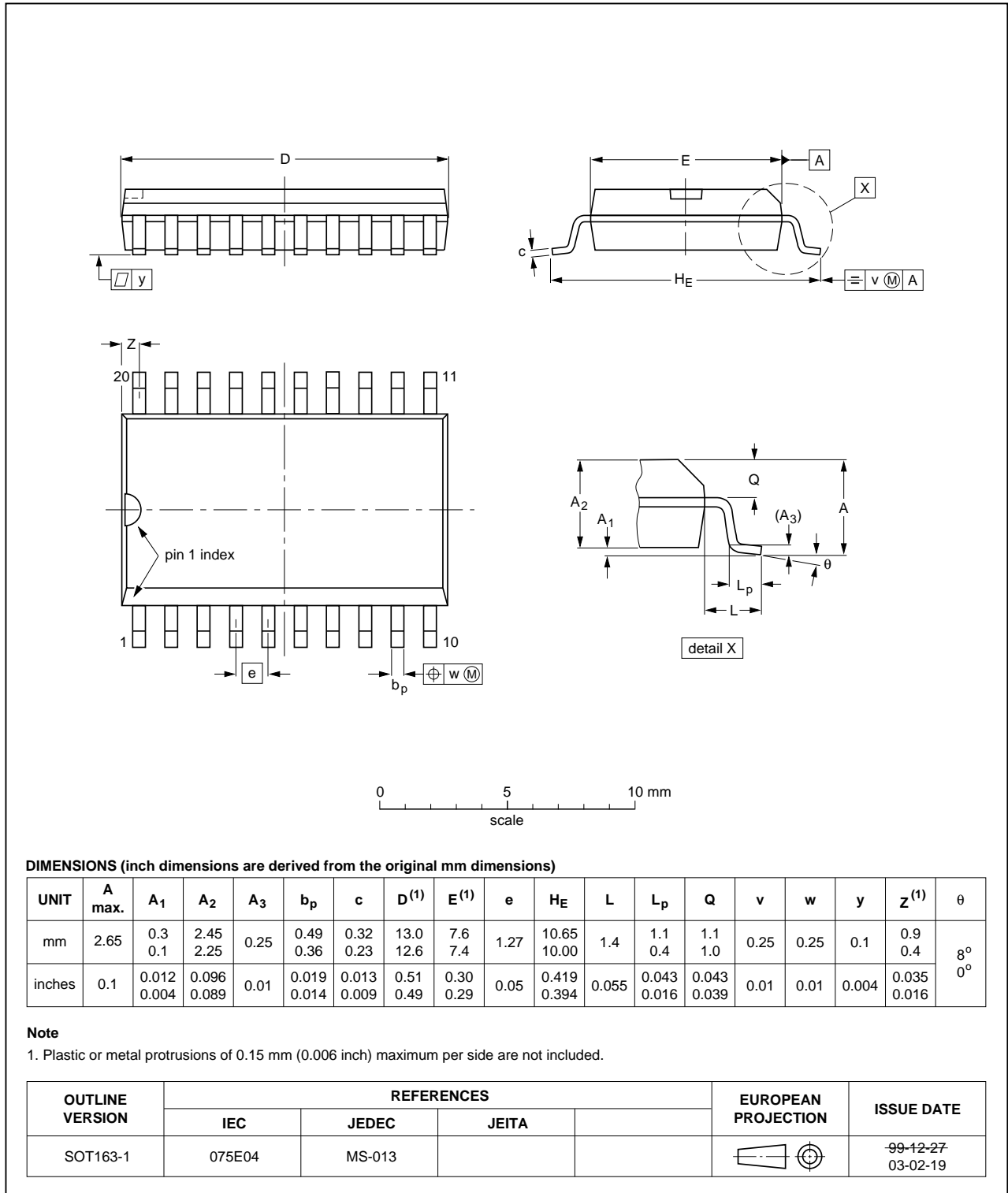


Fig 12. Package outline SOT163-1 (SO20)

SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1

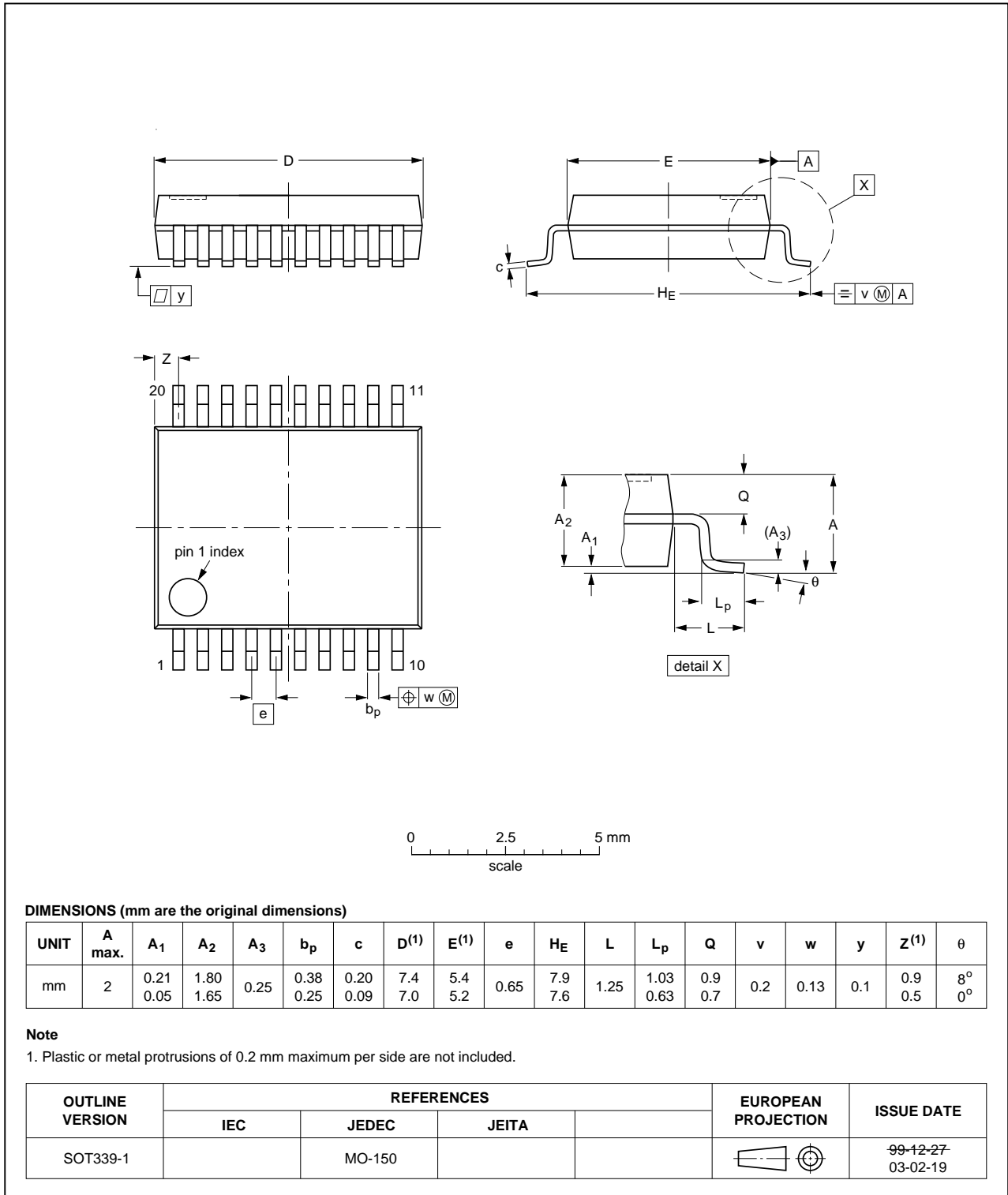


Fig 13. Package outline SOT339-1 (SSOP20)

TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



Fig 14. Package outline SOT360-1 (TSSOP20)

DHVQFN20: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body 2.5 x 4.5 x 0.85 mm

SOT764-1

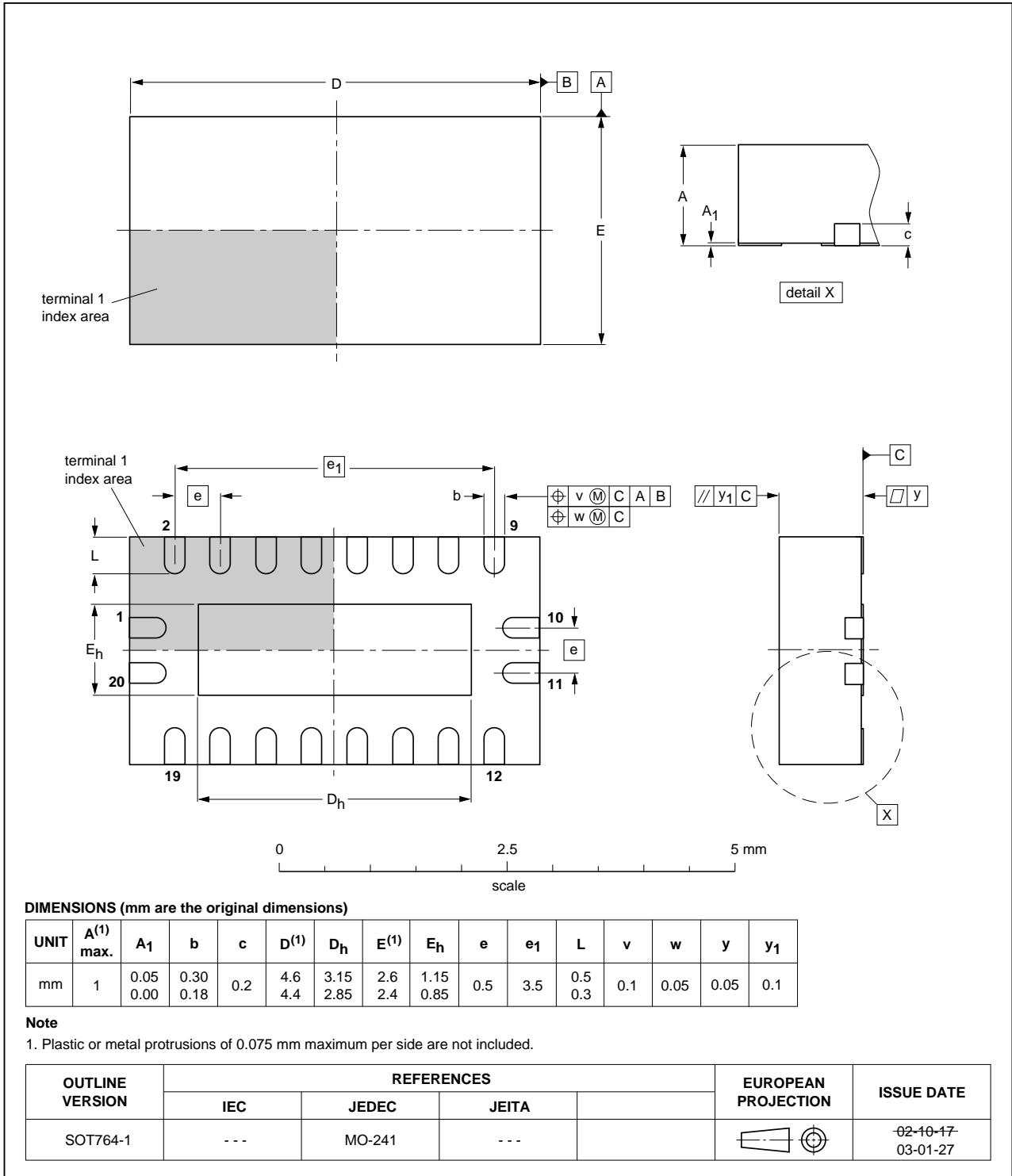


Fig 15. Package outline SOT764-1 (DHVQFN20)

13. Abbreviations

Table 10. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LVT573 v.8	20111122	Product data sheet	-	74LVT573 v.7
Modifications:	<ul style="list-style-type: none"> Legal pages updated. 			
74LVT573 v.7	20110912	Product data sheet	-	74LVT573 v.6
74LVT573 v.6	20110727	Product data sheet	-	74LVT573 v.5
74LVT573 v.5	20110629	Product data sheet	-	74LVT573 v.4
74LVT573 v.4	20080915	Product data sheet	-	74LVT573 v.3
74LVT573 v.3	20011217	Product data sheet	-	74LVT573 v.2
74LVT573 v.2	19980219	Product specification	-	-

15. Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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For sales office addresses, please send an email to: salesaddresses@nxp.com

17. Contents

1	General description	1
2	Features and benefits	1
3	Ordering information	2
4	Functional diagram	2
5	Pinning information	3
5.1	Pinning	3
5.2	Pin description	4
6	Functional description	4
6.1	Function table	4
7	Limiting values	4
8	Recommended operating conditions	5
9	Static characteristics	5
10	Dynamic characteristics	7
11	Waveforms	8
12	Package outline	10
13	Abbreviations	14
14	Revision history	14
15	Legal information	15
15.1	Data sheet status	15
15.2	Definitions	15
15.3	Disclaimers	15
15.4	Trademarks	16
16	Contact information	16
17	Contents	17

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